

<b>Notice of References Cited</b>	Application/Control No. 10/824,517		Applicant(s)/Patent Under Reexamination HOGENGOUT ET AL.	
	Examiner Huyen X. Vo		Art Unit 2626	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,574,595	06-2003	Mitchell et al.	704/242
*	B	US-5,857,169	01-1999	Seide, Frank	704/256.7
*	C	US-2002/0178004	11-2002	Chang et al.	704/246
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
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**NON-PATENT DOCUMENTS**

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